Electrically Benign Defect Behavior in Zinc Tin Nitride Revealed from First Principles

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Zinc tin nitride $(ZnSnN_2)$ is attracting growing interest as a nontoxic and earth-abundant photoabsorber for thin-film photovoltaics. Carrier transport in $ZnSnN_2$ and consequently cell performance are strongly affected by point defects with deep levels acting as carrier recombination centers. In this study, the point defects in $ZnSnN_2$ are revisited by careful first-principles modeling based on recent experimental and theoretical results. It is shown that $ZnSnN_2$ does not have low-energy defects with deep levels, in contrast to previously reported results. Therefore, $ZnSnN_2$ is more promising as a photoabsorber material than formerly considered.

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ZnSnN₂ has a wurtzite-derived structure with a minimum direct band gap of 1.4 eV [1,2], which is very close to the ideal Shockley-Queisser value of 1.34 eV [3]. In addition, the electron effective mass of $0.17m_0$ and its heavyhole mass of $2.00m_0$ are comparable or even superior to those of GaN (Fig. S2, Supplemental Material [4], and [5]). However, there are several fundamentally and technologically important issues regarding the use of ZnSnN₂ as a light absorption layer that need to be assessed: (i) Point-defect properties. It is necessary to identify any point defects with deep levels, because they trap electrons and/or holes and cause carrier recombination, leading to loss of cell efficiency. (ii) Unintentional n-type doping. The carrier electron concentration generally unintentionally increases up to 10^{21} cm⁻³ in ZnSnN₂ as well as other narrow-gap nitrides like InN, Zn₃N₂, and ScN [6-8]. For solar-cell applications, the carrier electron concentration needs to be lowered to around 10¹⁶–10¹⁸ cm⁻³. Besides, the photoabsorption onset is increased up to 2.4 eV [1,9,10] because of the Burstein-Moss (BM) shift [11,12], which raises considerable controversy regarding the fundamental gap of $ZnSnN_2$. The BM shift is also directly related to the formation of donor-type point defects. Understanding the point-defect properties of $ZnSnN_2$ is thus imperative to optimize its performance in photovoltaics.

Chen *et al.* [13] investigated native point defects and oxygen impurities in $ZnSnN_2$ with an ordered orthorhombic structure. They report that Sn-on-Zn antisite (Sn_{Zn}) and O-on-N (O_N) substitutional defects have low formation energies with deep donor levels and thus do not cause the BM shift in ZnSnN₂. However, given recent experimental and theoretical findings [1,2,9,10,14–16], this conclusion needs to be reviewed. This motivated us to reevaluate point defects in ZnSnN₂ including currently unexplored hydrogen impurities. Our results show that all the defects with deep levels are very high in energy and the abundant defects act as shallow donors. Considering these favorable defect properties together with its appropriate band gap and high absorption coefficient, ZnSnN₂ is a promising photoabsorber for thin-film photovoltaics.

Our theoretical investigation of the point defects in $ZnSnN_2$ is performed for the $Pna2_1$ orthorhombic structure with 16 atoms in the unit cell, referred to here as the ordered model. However, a certain level of disorder in the cation sublattice appears to be unavoidable because of the very low cation order-disorder transition temperature [2]. At low temperature, the disordered phase strictly retains the local charge neutrality, in which each N atom is necessarily coordinated by two Sn and two Zn atoms. We refer to such a structure as the disordered structure

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with local charge neutrality (DLCN). It is reported that the electronic structure of the DLCN is almost identical to that of the ordered structure [2,15]. Thus, the DLCN should be ideal as a photoabsorber, unless its defects are detrimental to its efficiency. We thus consider both ordered and DLCN models in our defect calculations. Note that cation disorder breaks local charge neutrality at very high temperature (>1750 K [2]). Some authors use special quasirandom structures (SQS) to examine the behavior of the cation disordered phase [9,10]. Such a fully random cation disordered model is not appropriate for ZnSnN₂ because its typical growth temperature is much lower than 1750 K [1,9,10,14,16]. Besides, when the charge neutrality is broken, a high concentration of Zn-on-Sn (Zn_{Sn}) defects is introduced. This situation should be avoided for photovoltaic applications because Zn_{Sn} defects give rise to deep levels, as discussed later.

Figure 1 shows the two models used to evaluate defect formation energies. The DLCN model is generated by Monte Carlo–simulated annealing of a 128-atom orthorhombic supercell. The DLCN model shown in Fig. 1 belongs to space group $Pna2_1$ and consists of a 32-atom unit cell, consistent with that reported elsewhere [2]. Note that there are infinite possible configurations for the DLCN models when different cell sizes are considered; however, within the 128-atom supercell, we found only one configuration owing to the strong geometrical constraint of the local charge neutrality.

First, we discuss the band gap of $ZnSnN_2$ because it is a central controversy in the research of this material.



FIG. 1. Atomic structures of the ordered and DLCN models of $ZnSnN_2$ used in this study. These models contain 128 atoms. Both structures belong to space group $Pna2_1$.

As the carrier electron concentration increases, the photoabsorption onset also increases due to the BM shift. The blueshift estimated from the Heyd-Scuseria-Ernzerhof (HSE06) hybrid functional calculations [31,32] is 0.2–2.3 eV when the carrier electron concentration is 10^{18} – 10^{21} cm^{-3} observed in experiments [1,9,10] (Fig. S6, Supplemental Material [4]). Thus, larger experimental band gaps than 1.4 eV could be attributed to the BM shift, as is also discussed by Lahourcade *et al.* [1] Second, the band gaps of fully cation-disordered systems are ill-defined because the minimum gap decreases as the model size increases [17]. In the case of $ZnSnN_2$, the density of states tends to continuously develop within the band gap when N atoms are coordinated by three or four Sn or Zn atoms, as discussed later. Note that this does not necessarily indicate metallic behavior because the defect states are discontinuous in real space. Refer to the Supplemental Material for a more detailed discussion considering SQS (Fig. S8 [4]).

We now discuss the energetics of point defects in ZnSnN₂. To investigate the site dependency in the DLCN model, we conduct over 300 point-defect calculations using the modified Perdew-Burke-Ernzerhof generalized gradient approximation tuned for solids (PBEsol GGA) [18]. We confirm that most of the defect species show only negligible site dependencies in energy, while the interstitial defects exhibit relatively large ones, probably due to the difference in neighboring cation configurations at the octahedral sites (Fig. S9, Supplemental Material [4]). Thus, we perform HSE06 calculations for a few configurations with lower energies in PBEsol calculations for each defect and show only the results of the lowest-energy configurations hereafter. Figure 2 shows the resultant formation energies of the native defects as well as hydrogen and oxygen impurities, which are ubiquitous in nitrides. Since ZnSnN₂ is only slightly more stable ($\Delta H_f = -0.015 \text{ eV/atom}$) than Zn metal, Sn metal, and N₂ molecules, based on HSE06 calculations, the growth condition does not significantly affect the formation energies under the equilibrium condition. Therefore, here, the chemical potentials of constituent elements are set at the point where Zn and Sn metals equilibrate with ZnSnN₂. As mentioned above, the standard HSE06 functional used in this study yields a direct gap of 1.4 eV. In the study by Chen et al., the Fock exchange ratio is increased to reproduce a reported experimental gap of 2.0 eV [1], although one of the authors attributes this larger gap to the BM shift and states that the fundamental gap is about 1.4 eV [1].

Before discussing the results, let us consider the technical details that can alter conclusions even qualitatively. Chen *et al.* [13] did not consider the finite cell-size effects when calculating defect formation energies and the reciprocal-space sampling is performed using only the Γ point. According to our calculated cell-size dependencies, a maximum error of 0.72 eV arises when the 128-atom supercell is used with these settings.



FIG. 2. Formation energies of point defects in ZnSnN₂ as a function of the Fermi level. (a),(b) Native defects and (c),(d) impurities in the (a),(c) ordered model and (b),(d) DLCN model. The valence-band maximum is set to the zero of the Fermi level and the upper limit corresponds to the conduction-band minimum. The defect species and sites are indicated by X_Y , where X means a vacancy (V) or an added element and Y is an interstitial site (i) or substitutional site. The chemical potentials are set at a point where the Zn and Sn metals equilibrate with ZnSnN₂. Note that shallow donor levels in the vicinity of the conduction-band minimum are designated by open circles (see text in detail). Note also that the Sn vacancy does not appear in panels (a) and (b) owing to its very high formation energy (see Fig. S12, Supplemental Material). The inset of (c) shows the atomic structure for H_i^+ . (e),(f) Band structures for the Sn_{Zn}^0 and Zn_{Sn}^0 in the 128-atom supercell of the ordered model. Note that Zn_{Sn}^0 shows spin polarization, and only the down-spin channel, which indicates two unoccupied deep localized states, is shown (see Fig. S14, Supplemental Material, for the up-spin channel). (g),(h) Squared wave functions of the highest occupied and the lowest unoccupied bands for Sn_{Zn}^0 and Zn_{Sn}^0 , respectively, highlighted by blue color in panels (e) and (f).

In this study, we decrease these errors using the extended Freysoldt–Neugebauer–Van de Walle (FNV) corrections [19,20] and $2 \times 2 \times 2$ Monkhorst-Pack *k*-point sampling for the 128-atom supercell. Consequently, the errors based on our test calculations are less than 0.06 eV. In the case of defects exhibiting hydrogenic states, a huge supercell including tens of thousands of atoms is usually required to avoid overlap between widespread defect orbitals [21]. When using the 128-atom supercell in ZnSnN₂, the thermodynamic transition levels of such defects are overestimated by a few tenths of an eV because of the defect–defect interaction (see Fig. S10, Supplemental Material [4]). Therefore, we discuss the transition levels associated with hydrogenic states only qualitatively.

Figures 2(a)-2(d) reveal that there is little difference between the defect formation energies of the ordered and DLCN models, which means that not only the bulk properties but also the point-defect properties are strongly correlated with its immediate coordination environment. This conclusion would also hold for similar cation-disordered systems such as ZnSnP₂ [22,23] and ZnGeN₂ [24] if the local charge neutrality is preserved. It is also notable that defects and impurities that show low formation energies simultaneously with deep levels do not exist when the Fermi level is located within the band gap. This is in stark contrast to the conclusion of a previous study [13], that the Zn interstitial (Zn_i) , Sn_{Zn} , nitrogen vacancy (V_N) , and O_N have deep defect levels and act as carrier recombination centers. This discrepancy is mainly caused by the aforementioned difference in the treatment of the cell-size corrections and k-point sampling.

As shown in Figs. 2(e) and 2(g), Sn_{Zn}^0 exhibits an occupied hydrogenic state, namely perturbed host state, while the localized defect state is not confirmed near the conduction-band minimum (CBM), which is different from the results by Chen *et al.* [13] Therefore, Sn_{Zn} is a dominant shallow donor among the native defects. Its formation energy becomes zero at the Fermi level that is 0.9 eV above the valence-band maximum (VBM) and hinders *p*-type conversion even with acceptor doping. V_N is a single shallow donor in the entire Fermi-level range but has a higher formation energy than that of Sn_{Zn} . In contrast, acceptor-type defect Zn_{Sn} forms two deep transition levels between the 0, -1, and -2 charge states.

Indeed, as seen in Figs. 2(f) and 2(h), Zn_{Sn}^0 shows two deep localized defect states within the band gap. However, the formation energy of Zn_{Sn} is rather high when the Fermi level is within the band gap. The other defects, namely, Zn vacancy (V_{Zn}), Sn vacancy (V_{Sn}), Sn interstitial (Sn_i), and N interstitial (N_i), create deep levels but have very high formation energies. It is also noteworthy that Sn_{Zn}^0 does not become a *DX* center ($V_{Zn} + Sn_i$) in our calculations unlike ZnSnP₂ [22], probably because of the high formation energies of V_{Zn} and Sn_i and/or the difference in crystal structures.

Oxygen and hydrogen impurities are energetically favorable at the N sites (O_N) and interstitial sites (H_i) , respectively. These impurities also act as single shallow donors and exhibit low formation energies even when the Fermi level is at the CBM. Orbital analyses indicate that their donor electrons are located at the perturbed conduction bands. Therefore, these impurities should primarily cause the BM shift. However, in the previous study [13], the origin of the high carrier electron concentration is attributed to the defect band originating from Sn_{Zn} and O_N , which is different from our results. H_i forms an N—H bond (1.01 Å) between the N and Zn atoms, as commonly observed for nitrides. We also find that anionic hydrogen H_i^{-1} is not stabilized even when the Fermi level is located at 1 eV above the CBM in ZnSnN₂ (see Fig. S12, Supplemental Material [4]), unlike in GaN [25].

In a recent paper, Fioretti et al. [16] show that annealing Zn-rich $Zn_{1+x}Sn_{1-x}N_2$ grown in a hydrogen atmosphere decreases its carrier electron concentration to $4 \times$ 10^{16} cm⁻³. They explain this observation from the viewpoint of hydrogen passivation of acceptors, i.e., $Zn_{Sn} + H_i$ in $Zn_{1+x}Sn_{1-x}N_2$ during growth, which lowers the driving force for the formation of other unintentional donors. Indeed, our results indicate that complexing with hydrogen is exothermic and drastically decreases the formation energy of acceptor Zn_{Sn} (Fig. S13 [4]); the binding energy, i.e., the energy change from isolated Zn_{Sn}^{-2} and H_i^+ to $(Zn_{Sn} + H_i)^-$ is -1.43 eV and that from isolated H_i^+ and $(Zn_{Sn} + H_i)^-$ to $(Zn_{Sn} + 2H_i)^0$ is -0.73 eV. Therefore, abundant Zn_{Sn} antisites are easily introduced by hydrogen passivation as Fioretti et al. discuss. We, however, emphasize that Zn_{Sn} antisites, which generate deep transition levels and trap minority carrier holes, persist even after removing the passivating hydrogen by postdeposition annealing. Moreover, the determination of the intrinsic band gap would be inhibited by the optical absorption related to the defect band.

Here, we propose an alternative route to achieving $ZnSnN_2$ with lower carrier electron concentration. In the above discussion, the chemical potentials are set at a point where the Zn and Sn metals equilibrate with $ZnSnN_2$. However, recent growth techniques such as reactive sputtering can be used to raise the chemical potential of N (μ_N) by up to +1 eV/N from that of an inactive

 N_2 molecule [26]. Consequently, metastable nitrides can be synthesized. A notable example is Cu₃N, in which μ_N needs to be at least +1.04 eV higher than that of an N₂ molecule [26]. When μ_N is increased to this value, we can use more advantageous conditions for lowering the carrier electron concentration. Figure 3 shows the formation energies of native defects and oxygen impurity under $\Delta \mu_{\rm N} =$ +1 eV/N and Zn-rich (Sn-poor) conditions (see Fig. S16 for details [4]). The equilibrium Fermi level is located at 0.70 eV from the CBM at 600 K, which assumes synthesis temperature of $ZnSnN_2$ [9,14]. In this situation, all the defect concentrations are less than 10¹⁴ cm⁻³ and the corresponding carrier concentration is $n = 1.9 \times 10^{14} \text{ cm}^{-3}$. One might expect that *p*-type conversion by acceptor doping is plausible in this condition as all the donor-type defects compensating holes are high in energy. However, it is found from extensive calculations for the impurities Li, Na, K, Cu, and C using the HSE06 functional (see Fig. S17, Supplemental Material [4]) that none of them act as effective acceptor dopants for ZnSnN2 because of deep acceptor levels or incorporation into interstitial sites. Thus, *p*-type conversion in $ZnSnN_2$ seems very difficult, as previously considered, even if compensating donor-type defects are sufficiently suppressed as in Fig. 3 [27].

Methods. First-principles calculations are performed using the projector augmented-wave (PAW) method [28,29] as implemented in VASP [30]. The PBEsol GGA [18] is used to calculate the total energies of various DLCN models and SQS with different sizes, and to check the site and cell-size dependencies of defect formation energies. The HSE06 hybrid functional [31,32] with standard parameters is used for the calculations of the band structure, density of states, and defect formation energies. The plane-wave cutoff energy is set to 550 eV for the lattice relaxation of the ordered and DLCN models without



FIG. 3. Same as Fig. 2, but the nitrogen chemical potential is increased by 1 eV under the Zn-rich condition (see text for details). Since hydrogen impurity could be reduced by postgrowth annealing, we consider only oxygen as an impurity, here. For comparison, the dashed lines show the Sn_{Zn} and Zn_{Sn} formation energies under the Zn-rich and Sn-rich condition considered in Fig. 2.

defects and 400 eV for the other calculations with fixed lattice constants. The residual forces are converged to less than 0.01 and 0.04 eV/Å for the calculations without and with defects, respectively. Spin polarization is considered for all the defect calculations using the HSE06 functional.

The formation energy of a point defect is calculated as [19]

$$E_f[D^q] = \{E[D^q] + E_{\text{corr}}[D^q]\} - E_P + \sum n_i \mu_i + q(\epsilon_{\text{VBM}} + \Delta \epsilon_F), \qquad (1)$$

where $E[D^q]$ and E_P are the total energies of the supercell with defect D in charge state q and the supercell without a defect, respectively. n_i is the number of removed $(n_i > 0)$ or added $(n_i < 0)$ *i*-type atoms and μ_i is the chemical potential representing the growth conditions. The referenced competing phases used are hexagonal Zn, cubic Sn, wurtzite ZnO, and N₂ and H₂ molecules. ϵ_{VBM} is the energy level of the VBM, and $\Delta \epsilon_F$ is the Fermi level (ϵ_F) with respect to ϵ_{VBM} . Therefore, $\epsilon_F = \epsilon_{\text{VBM}} + \Delta \epsilon_F$. $E_{\text{corr}}[D^q]$ corresponds to the correction energy for a finite supercell-size error associated with spurious electrostatic interactions between charged defects. We use our extended FNV correction scheme [19] in the calculations. More computational details are described in the Supplemental Material [4].

Both DLCN and SQS models are generated by Monte Carlo–simulated annealing using in-house and CLUPAN codes [33], respectively (see Fig. S5, Supplemental Material, for more details [4]).

Conclusions. We revisited, theoretically, the point defects in $ZnSnN_2$ by realistic modeling of its disordered phase with the local charge neutrality. Our calculations reveal that the ordered and DLCN models exhibit nearly the same stability, volumes, electronic structures, and even point-defect properties, indicating these properties are determined mainly by the immediate coordination environment. It is also found that low-energy defects with deep levels are absent in $ZnSnN_2$, and therefore there is less carrier recombination caused by point defects than thought previously. Furthermore, a possible route to $ZnSnN_2$ with lower carrier electron concentration using nonequilibrium growth techniques is proposed. Our study unveils the further potential of $ZnSnN_2$ as a photoabsorber in thin-film photovoltaics.

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